



### Electrical Characteristics of the IGBT $T_{vj}=25^{\circ}\text{C}$ , unless otherwise noted

Parameter	Symbol	Test condition	Min.	Typ.	Max.	Unit
<b>OFF</b>						
Collector Emitter Breakdown Voltage	$BV_{CES}$	$V_{GE} = 0V, I_C = 1mA$	650	--	--	V
Zero Gate Voltage Collector Current	$I_{CES}$	$V_{CE} = 650V, V_{GE} = 0V$	--	--	1	mA
Gate Emitter Leakage Current	$I_{GES}$	$V_{CE} = 0V, V_{GE} = 20V$	--	--	250	nA
Integrated Gate Resistance	$R_{G(int)}$	$f = 1MHz, \text{Open Collector}$	--	3.9	--	
<b>ON</b>						
Gate Emitter Threshold Voltage	$V_{GE(TH)}$	$V_{GE} = V_{CE}, I_C = 40mA$	4.5	6.0	7.5	V
Collector Emitter Saturation Voltage	$V_{CE(SAT)}$	$V_{GE} = 15V, I_C = 40A, T_{vj} = 25$	--	1.60	2.10	V
		$V_{GE} = 15V, I_C = 40A, T_{vj} = 125$	--	1.81	--	V
		$V_{GE} = 15V, I_C = 40A, T_{vj} = 175$	--	1.94	--	V
<b>DYNAMIC</b>						
Input Capacitance	$C_{IES}$	$V_{CE} = 30V$ $V_{GE} = 0V$ $f = 1MHz$	--	2274	--	pF
Output Capacitance	$C_{OES}$		--	114	--	pF
Reverse Transfer Capacitance	$C_{RES}$		--	72	--	pF
Total Gate Charge	$Q_g$	$V_{CC} = 400V, I_C = 40A$ $V_{GE} = 15V$	--	121	182	nC
Gate-Emitter Charge	$Q_{ge}$		--	15	22	nC
Gate-Collector Charge	$Q_{gc}$		--	59	89	nC
<b>SWITCHING</b> (Note 3)						
Turn-On Delay Time	$t_{d(on)}$	$V_{CC} = 400V, I_C = 20A$ $R_G = 5, V_{GE} = 15V$ Inductive Load, $T_{vj} = 25$	--	25	--	ns
Rise Time	$t_r$		--	18	--	ns
Turn-Off Delay Time	$t_{d(off)}$		--	126	--	ns
Fall Time	$t_f$		--	34	--	ns
Turn-On Switching Loss	$E_{ON}$		--	0.36	--	mJ
Turn-Off Switching Loss	$E_{OFF}$	--	0.26	--	mJ	
Total Switching Loss	$E_{TS}$	--	0.62	--	mJ	
Turn-On Delay Time	$t_{d(on)}$	$V_{CC} = 400V, I_C = 40A$ $R_G = 5, V_{GE} = 15V$ Inductive Load, $T_{vj} = 25$	--	28	--	ns
Rise Time	$t_r$		--	29	--	ns
Turn-Off Delay Time	$t_{d(off)}$		--	108	--	ns
Fall Time	$t_f$		--	37	--	ns
Turn-On Switching Loss	$E_{ON}$		--	1.06	1.59	mJ
Turn-Off Switching Loss	$E_{OFF}$		--	0.55	0.83	mJ
Total Switching Loss	$E_{TS}$		--	1.61	2.42	mJ





